

Substitute for form 1449/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  Sheet 1 of 2	<b>Complete if Known</b>	
	<b>Application Number</b>	10/815,604
	<b>Filing Date</b>	03/31/2004
	<b>First Inventor</b>	HO, Andrew
	<b>Art Unit</b>	2611
	<b>Examiner</b>	Perilla, Jason
	<b>Atty Docket #</b>	
	<b>Rambus #</b>	RA290.CIP1.US

US Patent Documents						
Examiner Initials*	Cite No.	Document No.	Date (MM- DD-YYYY)	Patentee	Class	Subclass
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<b>Examiner Signature:</b>	/Jason Perilla/	<b>Date Considered:</b>	09/08/2009
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Examiner Initials*	Cite No.	Document No.	Date (MM- DD-YYYY)	Patentee	Class	Subclass
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